

**Notice of References Cited**

Application/Control No.

10/050,667

Applicant(s)/Patent Under

Reexamination

ANDRIESEN, HIERONYMUS

Examiner

Thao X Le

Art Unit

2814

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0110701	08-2002	WEHRMANN et al.	428/690
	B	US-6,379,583	04-2002	Gray et al.	252/301.4R
	C	US-2002/0149025	10-2002	Andriessen	257/98
	D	US-2002/0151094	10-2002	Andriessen	438/29
	E	US-5,073,303	12-1991	Reid, Jerome L.	252/584
	F	US-5,252,448	10-1993	Nishio et al.	430/523
	G	US-2001/0039060	11-2001	Siiman et al.	436/525
	H	US-6,066,441	05-2000	Jansen et al.	430/440
	I	US-6,352,791	03-2002	Fink et al.	428/690
	J	US-6,488,555	12-2002	Pichler et al.	445/24
	K	US-2002/0163005	11-2002	Kojima et al.	257/80
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

*		U	
		V	
		W	
		X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.